





RELIABILITY DATA LT1640 / LT1641 / LT4250

8/21/2006

• OPERATING LIFE TEST

PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS ⁽¹⁾ AT +125°C	NUMBER OF ⁽²⁾ FAILURES
PLASTIC DIP	50	0040	0040	50.00	0
SOIC/SOT/MSOP	454	9813	0213	214.69	0
	504			264.69	0

• PRESSURE COOKER TEST AT 15 PSIG, +121°C

PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS	NUMBER OF FAILURES
PLASTIC DIP	704	9821	0205	67.34	0
SOIC/SOT/MSOP	4,206 4.910	9821	0409	579.34	0
	4,910			646.69	0

• TEMP CYCLE FROM -65°C to +150°C

PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES
PLASTIC DIP	554	9830	0205	214.60	0
SOIC/SOT/MSOP	2,111	9830	0409	979.61	0
	2,665			1,194.21	0

• THERMAL SHOCK FROM -65°C to +150°C

PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES
PLASTIC DIP	254	0110	0205	164.30	0
SOIC/SOT/MSOP	1,229	9830	0409	664.80	0
	1,483			829.10	0

- (1) Assumes Activation Energy = 1.0 Electron Volts
- (2) Failure Rate Equivalent to +55°C, 60% Confidence Level = 6.95 FITS
- (3) Mean Time Between Failures in Years = 16,414

Note: 1 FIT = 1 Failure in One Billion Hours.

Form: 00-03-6209B. R375